

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 205002US2		SERIAL NO. 09/851,387	
<div style="border: 1px solid black; border-radius: 50%; padding: 10px; display: inline-block; text-align: center;"> OIPE LIST OF REFERENCES CITED BY APPLICANT JUN 01 2004 U.S. PATENT & TRADEMARK OFFICE </div>				APPLICANT Mitsuhiro NADA			
				FILING DATE May 9, 2001		GROUP 2859	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>Al</i>	AA	3,622,849	11-23-71	Kelley, Jr. et al			
<i>Al</i>	AB	4,330,809	5-18-82	Stanley			
<i>Al</i>	AC	5,920,617	7-6-99	Berger et al			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
<i>Al</i>	AO	DE 19641074	4-9-98	Germany	<i>abstr</i>	x	
	AP	JP 2-60151	2-28-90	Japan w/English Abstract		x	
	AQ	JP 5-284692	10-29-93	Japan w/English Abstract		x	
	AR	JP 5-502303	4-22-93	Japan w/corresponding international patent application (WO 91/10924)		x	
	AS	JP 7-227047	8-22-95	Japan w/English Abstract		x	
	AT	JP 8-121293	5-14-96	Japan w/English Abstract		x	
	AU	JP 10-213492	8-11-98	Japan w/English Abstract		x	
<i>Al</i>	AV	JP 2-136465	11-14-90	Japan w/English Abstract		x	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner <i>C. V. Chittag</i>					<input type="checkbox"/> Additional References sheet(s) attached Date Considered <i>09/14/2004</i>		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							